

CSD18511KTT 40V N-Channel NexFET™ Power MOSFET

1 Features

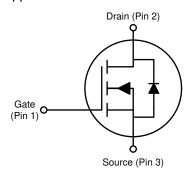
- Low Q_g and Q_{gd}
- Low R_{DS(ON)}
- Low-thermal resistance
- Avalanche rated
- Lead-free terminal plating
- · RoHS compliant
- Halogen free
- D²PAK plastic package

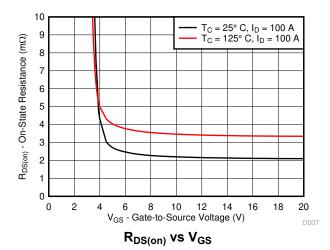
2 Applications

- Secondary side synchronous rectifier
- Motor control

3 Description

This 40V, 2.1mΩ, D²PAK (TO-263) NexFET[™] power MOSFET is designed to minimize losses in power conversion applications.





Product Summary

T _A = 25°	С	TYPICAL VA	UNIT	
V _{DS}	Drain-to-Source Voltage 40			
Qg	Gate Charge Total (10V)	63.9		nC
Q _{gd}	Gate Charge Gate-to-Drain	9.7	nC	
В	Drain-to-Source On-Resistance	V _{GS} = 4.5V 3.2		mΩ
R _{DS(on)}	Drain-to-Source On-Resistance	V _{GS} = 10V 2.1		11177
V _{GS(th)}	Threshold Voltage	1.8		V

Device Information

DEVICE	QTY	MEDIA	PACKAGE ⁽¹⁾	SHIP
CSD18511KTT	500	40.1.1.5.1	D ² PAK	Tape
CSD18511KTTT	50	13-Inch Reel	Plastic Package	and Reel

Absolute Maximum Ratings

T _A = 2	25°C	VALUE	UNIT	
V _{DS}	Drain-to-Source Voltage	40	V	
V_{GS}	Gate-to-Source Voltage	±20	V	
	Continuous Drain Current (Package Limited)	110		
I _D	Continuous Drain Current (Silicon Limited), T _C = 25°C	194	Α	
	Continuous Drain Current (Silicon Limited), T _C = 100°C	137		
I _{DM}	Pulsed Drain Current ⁽¹⁾	400	Α	
P_D	Power Dissipation	188	W	
T _J , T _{stg}	Operating Junction, Storage Temperature	-55 to 175	°C	
E _{AS}	Avalanche Energy, Single Pulse $I_D = 56A$, $L = 0.1$ mH, $R_G = 25\Omega$	156	mJ	

For all available packages, see the orderable addendum at the end of the data sheet.

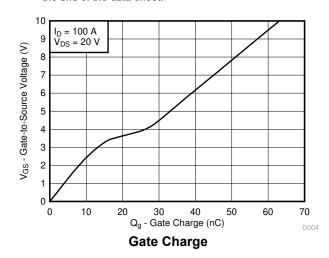




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4 Specifications

4.1 Thermal Information

T_A = 25°C (unless otherwise stated)

	THERMAL METRIC	MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Junction-to-case thermal resistance			0.8	°C/W
R _{θJA}	Junction-to-ambient thermal resistance			62	°C/W

4.2 Electrical Characteristics

T_A = 25°C (unless otherwise stated)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
STATIC	CHARACTERISTICS		<u>'</u>			
BV _{DSS}	Drain-to-source voltage	$V_{GS} = 0V, I_D = 250\mu A$	40			V
I _{DSS}	Drain-to-source leakage current	V _{GS} = 0V, V _{DS} = 32V			1	μΑ
I _{GSS}	Gate-to-source leakage current	V _{DS} = 0V, V _{GS} = 20V			100	nA
V _{GS(th)}	Gate-to-source threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1.5	1.8	2.4	V
	Drain-to-source on-resistance	V _{GS} = 4.5V, I _D = 100A		3.2	4.2	mΩ
R _{DS(on)}	Diam-to-source on-resistance	V _{GS} = 10V, I _D = 100A		2.1	2.6	11122
9 _{fs}	Transconductance	V _{DS} = 4V, I _D = 100A		249		S
DYNAM	IC CHARACTERISTICS				'	
C _{iss}	Input capacitance			4570	5940	pF
C _{oss}	Output capacitance	$V_{GS} = 0V, V_{DS} = 20V, f = 1MHz$		454	591	pF
C _{rss}	Reverse transfer capacitance			235	306	pF
R_G	Series gate resistance			0.9	1.8	Ω
$\overline{Q_g}$	Gate charge total (4.5V)			31		nC
Qg	Gate charge total (10V)			64		nC
Q _{gd}	Gate charge gate-to-drain	V _{DS} = 20V, I _D = 100A		9.7		nC
Q _{gs}	Gate charge gate-to-source			17.9		nC
Q _{g(th)}	Gate charge at V _{th}			7.4		nC
Q _{oss}	Output charge	V _{DS} = 20V, V _{GS} = 0V		20.7		nC
t _{d(on)}	Turnon delay time			8		ns
t _r	Rise time	V _{DS} = 20V, V _{GS} = 10V,		6		ns
t _{d(off)}	Turnoff delay time	$I_{DS} = 100A$, $R_G = 0\Omega$		17		ns
t _f	Fall time			3		ns
DIODE (CHARACTERISTICS		·		'	
V _{SD}	Diode forward voltage	I _{SD} = 100A, V _{GS} = 0V		0.9	1.0	V
Q _{rr}	Reverse recovery charge	V _{DS} = 20V, I _F = 100A,		62		nC
t _{rr}	Reverse recovery time	di/dt = 300A/µs		31		ns



4.3 Typical MOSFET Characteristics

T_A = 25°C (unless otherwise stated)

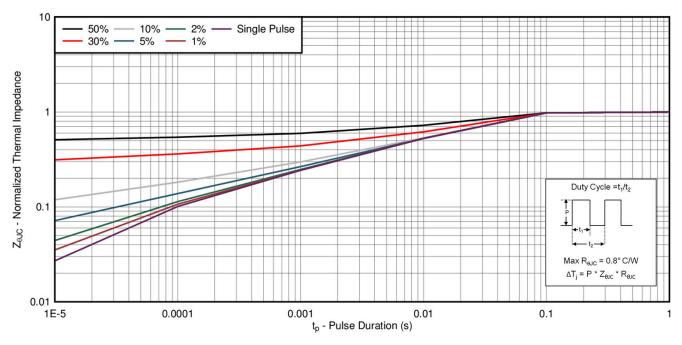


Figure 4-1. Transient Thermal Impedance

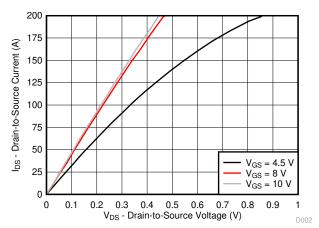


Figure 4-2. Saturation Characteristics

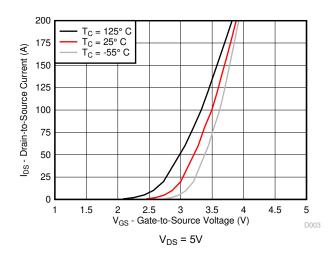


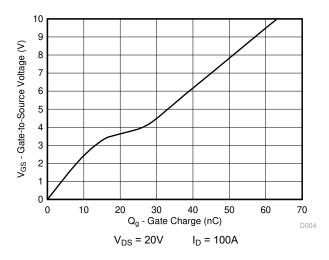
Figure 4-3. Transfer Characteristics

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4.3 Typical MOSFET Characteristics (continued)

T_A = 25°C (unless otherwise stated)



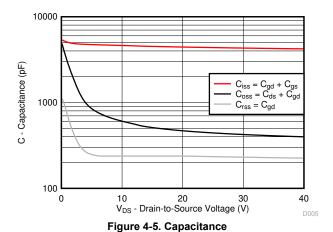
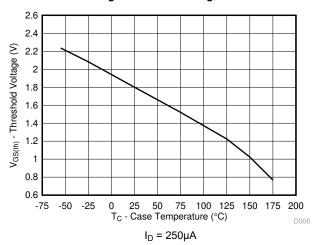


Figure 4-4. Gate Charge



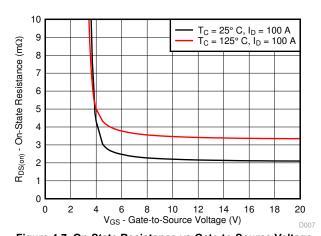
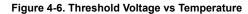
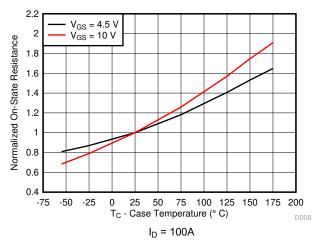


Figure 4-7. On-State Resistance vs Gate-to-Source Voltage





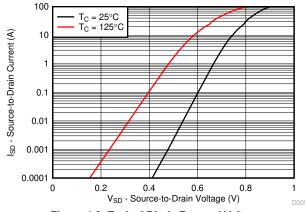


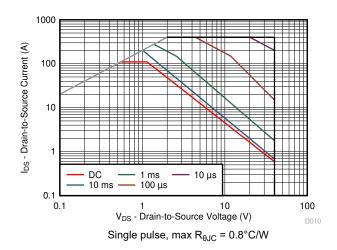
Figure 4-9. Typical Diode Forward Voltage

Figure 4-8. Normalized On-State Resistance vs Temperature



4.3 Typical MOSFET Characteristics (continued)

T_A = 25°C (unless otherwise stated)



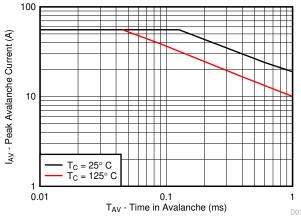


Figure 4-11. Single Pulse Unclamped Inductive Switching

Figure 4-10. Maximum Safe Operating Area

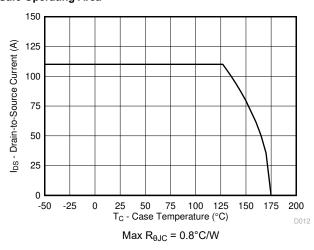


Figure 4-12. Maximum Drain Current vs Temperature

Product Folder Links: CSD18511KTT

5 Device and Documentation Support

5.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

5.2 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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5.3 Trademarks

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5.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

5.5 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

6 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision * (July 2017) to Revision A (June 2025)

Page



7 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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PACKAGING INFORMATION

Orderable part number	Status	Material type	Package Pins	Package qty Carrier	RoHS	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
						(4)	(5)		
CSD18511KTT	Active	Production	DDPAK/ TO-263 (KTT) 2	500 LARGE T&R	ROHS Exempt	SN	Level-2-260C-1 YEAR	-55 to 175	CSD18511KTT
CSD18511KTT.B	Active	Production	DDPAK/ TO-263 (KTT) 2	500 LARGE T&R	ROHS Exempt	SN	Level-2-260C-1 YEAR	-55 to 175	CSD18511KTT
CSD18511KTTT	Active	Production	DDPAK/ TO-263 (KTT) 2	50 SMALL T&R	ROHS Exempt	SN	Level-2-260C-1 YEAR	-55 to 175	CSD18511KTT
CSD18511KTTT.B	Active	Production	DDPAK/ TO-263 (KTT) 2	50 SMALL T&R	ROHS Exempt	SN	Level-2-260C-1 YEAR	-55 to 175	CSD18511KTT

⁽¹⁾ Status: For more details on status, see our product life cycle.

- (3) RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.
- (4) Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.
- (5) MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.
- (6) Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.



PACKAGE OPTION ADDENDUM

www.ti.com 7-Nov-2025

PACKAGE MATERIALS INFORMATION

www.ti.com 25-Sep-2024

TAPE AND REEL INFORMATION





	-
A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	,	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CSD18511KTT	DDPAK/ TO-263	KTT	2	500	330.0	24.4	10.8	16.3	5.11	16.0	24.0	Q2
CSD18511KTTT	DDPAK/ TO-263	KTT	2	50	330.0	24.4	10.8	16.3	5.11	16.0	24.0	Q2



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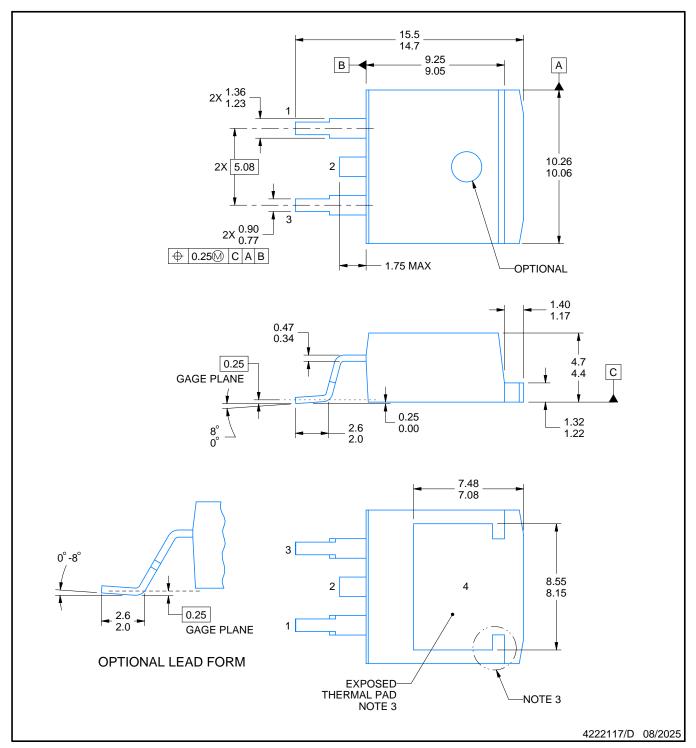


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CSD18511KTT	DDPAK/TO-263	ктт	2	500	340.0	340.0	38.0
CSD18511KTTT	DDPAK/TO-263	KTT	2	50	340.0	340.0	38.0



TRANSISTOR OUTLINE



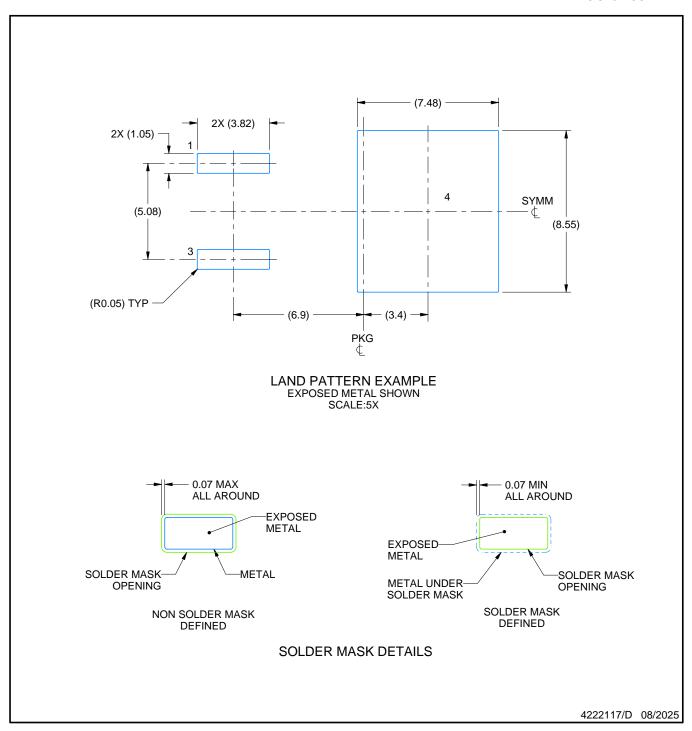
NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.
- 3. Features may not exist and shape may vary per different assembly sites. Pin 2 and Pin 4 connected. 4. Reference JEDEC registration TO-263.



TRANSISTOR OUTLINE

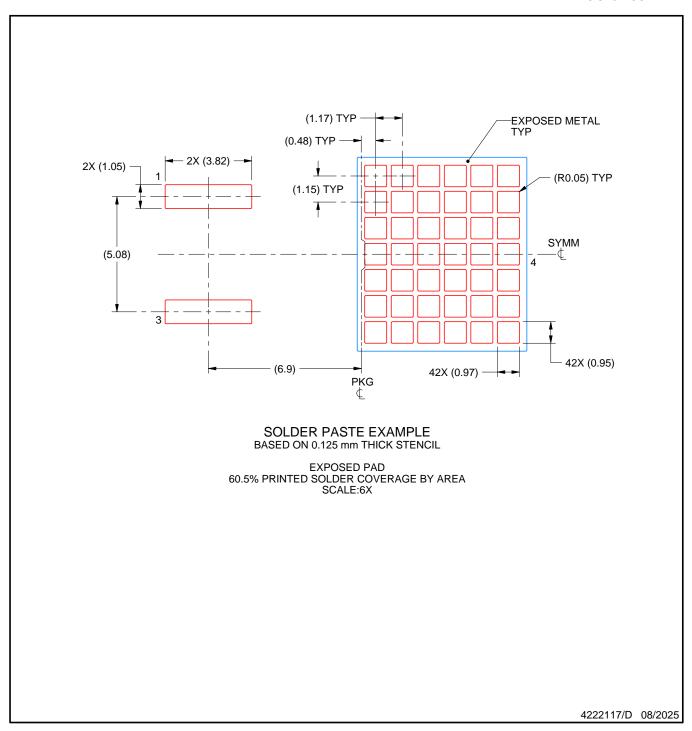


NOTES: (continued)

- 5. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature numbers SLMA002(www.ti.com/lit/slma004) and SLMA004 (www.ti.com/lit/slma004).
- 6. Vias are optional depending on application, refer to device data sheet. It is recommended that vias under paste be filled, plugged or tented.



TRANSISTOR OUTLINE



NOTES: (continued)

- 7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

 8. Board assembly site may have different recommendations for stencil design.



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